## Power MOSFET

| PRODUCT SUMMARY |  |  |
| :--- | :--- | :--- |
| $\mathrm{V}_{\mathrm{DS}}(\mathrm{V})$ at $\mathrm{T}_{\mathrm{J}}$ max. | 560 |  |
| $\mathrm{R}_{\mathrm{DS}(\mathrm{on})}(\Omega)$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 0.225 |
| $\mathrm{Q}_{\mathrm{g}}(\mathrm{Max}).(\mathrm{nC})$ | 76 |  |
| $\mathrm{Q}_{\mathrm{gs}}(\mathrm{nC})$ | 21 |  |
| $\mathrm{Q}_{\mathrm{gd}}(\mathrm{nC})$ | 29 |  |
| Configuration | Single |  |

TO-220AB

## FEATURES

- Low Figure-of-Merit $\mathrm{R}_{\text {on }} \times \mathrm{Q}_{\mathrm{g}}$
- 100 \% Avalanche Tested
- High Peak Current Capability
- dV/dt Ruggedness
- Improved $t_{r r} / Q_{r r}$
- Improved Gate Charge
- High Power Dissipations Capability
- Compliant to RoHS Directive 2002/95/EC


Available

| ORDERING INFORMATION |  |
| :--- | :---: |
| Package | TO-220AB |
| Lead $(\mathrm{Pb})$-free | SiHP18N50C-E3 |


| ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathbf{C}}=25^{\circ} \mathrm{C}$, unless otherwise noted) |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER |  |  | SYMBOL | LIMIT | UNIT |
| Drain-Source Voltage |  |  | $\mathrm{V}_{\mathrm{DS}}$ | 500 | V |
| Gate-Source Voltage |  |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 30$ |  |
| Continuous Drain Current ( $\left.\mathrm{T}_{J}=150{ }^{\circ} \mathrm{C}\right)^{\text {a }}$ | $\mathrm{V}_{\mathrm{GS}}$ at 10 V | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | 18 | A |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 11 |  |
| Pulsed Drain Current ${ }^{\text {b }}$ |  |  | $\mathrm{I}_{\mathrm{DM}}$ | 72 |  |
| Linear Derating Factor |  | TO-220AB |  | 1.8 | W/ ${ }^{\circ} \mathrm{C}$ |
| Single Pulse Avalanche Energy ${ }^{\text {c }}$ |  |  | $\mathrm{E}_{\text {AS }}$ | 361 | mJ |
| Maximum Power Dissipation |  | TO-220AB | $\mathrm{P}_{\mathrm{D}}$ | 223 | W |
| Peak Diode Recovery dV/dt ${ }^{\text {d }}$ |  |  | dV/dt | 5 | V/ns |
| Operating Junction and Storage Temperature Range |  |  | $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\text {stg }}$ | -55 to + 150 | ${ }^{\circ} \mathrm{C}$ |
| Soldering Recommendations (Peak Temperature) ${ }^{\text {d }}$ | for 10 s |  |  | 300 |  |

## Notes

a. Drain current limited by maximum junction temperature.
b. Repetitive rating; pulse width limited by maximum junction temperature.
c. $\mathrm{V}_{\mathrm{DD}}=50 \mathrm{~V}$, starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{L}=2.5 \mathrm{mH}, \mathrm{R}_{\mathrm{g}}=25 \Omega, \mathrm{I}_{\mathrm{AS}}=17 \mathrm{~A}$.
d. $\mathrm{I}_{\mathrm{SD}} \leq 18 \mathrm{~A}, \mathrm{dl} / \mathrm{dt} \leq 380 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq \mathrm{V}_{\mathrm{DS}}, \mathrm{T}_{\mathrm{J}} \leq 150^{\circ} \mathrm{C}$.
e. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS |  |  |  |  |  |  |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER SYMBOL TYP. MAX. UNIT  <br> Maximum Junction-to-Ambient TO-220 $\mathrm{R}_{\text {thJA }}$ - 62 ${ }^{\circ} \mathrm{C} / \mathrm{W}$ <br> Maximum Junction-to-Case (Drain) TO-220 $\mathrm{R}_{\text {thJc }}$ - 0.56  |  |  |  |  |  |  |


| SPECIFICATIONS ( $\mathrm{T}_{\mathbf{J}}=25^{\circ} \mathrm{C}$, unless otherwise noted) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TEST CONDITIONS |  | MIN. | TYP. | MAX. | UNIT |
| Static |  |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | $V_{\text {DS }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 500 | - | - | V |
| $V_{\text {DS }}$ Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{DS}} / \mathrm{T}_{\mathrm{J}}$ | Reference to $25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}$ |  | - | 0.6 | - | V/ ${ }^{\circ} \mathrm{C}$ |
| Gate-Source Threshold Voltage ( N ) | $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 3.0 | - | 5.0 | V |
| Gate-Source Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 30 \mathrm{~V}$ |  | - | - | $\pm 100$ | nA |
| Zero Gate Voltage Drain Current | IdSs | $\mathrm{V}_{\mathrm{DS}}=500 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | - | - | 25 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=400 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | - | - | 250 |  |
| Drain-Source On-State Resistance | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ | - | 0.225 | 0.270 | $\Omega$ |
| Forward Transconductance ${ }^{\text {a }}$ | $\mathrm{g}_{\mathrm{fs}}$ | $\mathrm{V}_{\mathrm{DS}}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ |  | - | 6.4 | - | S |
| Dynamic |  |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{DS}}=25 \mathrm{~V}, \\ \mathrm{f}=1.0 \mathrm{MHz} \\ \hline \end{gathered}$ |  | - | 2451 | 2942 | pF |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  |  | - | 300 | 360 |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | - | 26 | 32 |  |
| Internal Gate Resistance | $\mathrm{R}_{\mathrm{g}}$ | $\mathrm{f}=1.0 \mathrm{MHz}$, open drain |  | - | 1.1 | - | $\Omega$ |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=18 \mathrm{~A}, \mathrm{~V}_{\mathrm{DS}}=400 \mathrm{~V}$ | - | 65 | 76 | nC |
| Gate-Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  |  | - | 21 | - |  |
| Gate-Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  |  | - | 29 | - |  |
| Turn-On Delay Time | $t_{\text {d(on) }}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=250 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=18 \mathrm{~A} \\ & \mathrm{R}_{\mathrm{g}}=7.5 \Omega, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{aligned}$ |  | - | 80 | - | ns |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | - | 27 | - |  |
| Turn-Off Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{off})}$ |  |  | - | 32 | - |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | - | 44 | - |  |
| Drain-Source Body Diode Characteristics |  |  |  |  |  |  |  |
| Continuous Source-Drain Diode Current | Is | MOSFET symbol <br> showing the integral reverse $\mathrm{p}-\mathrm{n}$ junction diode |  | - | - | 18 | A |
| Pulsed Diode Forward Current | $I_{\text {SM }}$ |  |  | - | - | 72 |  |
| Body Diode Voltage | $\mathrm{V}_{\mathrm{SD}}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{S}}=18 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | - | - | 1.5 | V |
| Body Diode Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\begin{gathered} \mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=\mathrm{I}_{\mathrm{S}}, \\ \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}, \mathrm{~V}_{\mathrm{R}}=35 \mathrm{~V} \end{gathered}$ |  | - | 503 | - | ns |
| Body Diode Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  |  | - | 6.7 | - | $\mu \mathrm{C}$ |
| Reverse Recovery Current | $\mathrm{I}_{\text {RRM }}$ |  |  | - | 30 | - | A |

## Note

a. Repetitive rating; pulse width limited by maximum junction temperature.

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TYPICAL CHARACTERISTICS $\left(25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Fig. 1 - Typical Output Characteristics, $\mathrm{T}_{\mathrm{C}}=150^{\circ} \mathrm{C}$


Fig. 2 - Typical Output Characteristics, $\mathrm{T}_{\mathrm{C}}=150^{\circ} \mathrm{C}$


Fig. 3 - Typical Transfer Characteristics


Fig. 4 - Normalized On-Resistance vs. Temperature


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage


Fig. 7 - Typical Source-Drain Diode Forward Voltage


Fig. 8 - Maximum Safe Operating Area


Fig. 9 - Maximum Drain Current vs. Case Temperature


Fig. 10 - Normalized Thermal Transient Impedance, Junction-to-Case


Fig. 11a - Switching Time Test Circuit


Fig. 11b - Switching Time Waveforms


Fig. 12a - Unclamped Inductive Test Circuit


Fig. 12b - Unclamped Inductive Waveforms


Fig. 13a - Basic Gate Charge Waveform


Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



Note
a. $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$ for logic level devices

Fig. 14 - For N -Channel

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TO-220AB


| DIM. | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN. | MAX. | MIN. | MAX. |
| A | 4.25 | 4.65 | 0.167 | 0.183 |
| b | 0.69 | 1.01 | 0.027 | 0.040 |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 |
| c | 0.36 | 0.61 | 0.014 | 0.024 |
| D | 14.85 | 15.49 | 0.585 | 0.610 |
| E | 10.04 | 10.51 | 0.395 | 0.414 |
| e | 2.41 | 2.67 | 0.095 | 0.105 |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 |
| F | 1.14 | 1.40 | 0.045 | 0.055 |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 |
| L | 13.35 | 14.02 | 0.526 | 0.552 |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 |
| $\varnothing$ P | 3.54 | 3.94 | 0.139 | 0.155 |
| Q | 2.60 | 3.00 | 0.102 | 0.118 |
| ECN: X10-0416-Rev. M, 01-Nov-10 |  |  |  |  |
| DWG: 5471 |  |  |  |  |

Note

* $\mathrm{M}=1.32 \mathrm{~mm}$ to 1.62 mm (dimension including protrusion) Heatsink hole for HVM


## TO-220 FULLPAK (HIGH VOLTAGE)



## Notes

1. To be used only for process drawing.
2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
3. All critical dimensions should $C$ meet $C_{p k}>1.33$.
4. All dimensions include burrs and plating thickness.
5. No chipping or package damage.

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